

<b>Notice of References Cited</b>		Application/Control No. 10/572,779	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
		Examiner HENRY S. HU	Art Unit 1796	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,650,472	07-1997	Tatemoto et al.	526/254
*	B	US-7,309,743 B2	12-2007	Kawasaki et al.	525/326.2
*	C	US-5,565,512	10-1996	Saito et al.	525/340
*	D	US-2002/0183457 A1	12-2002	Hintzer et al.	525/326.2
*	E	US-2003/0125463 A1	07-2003	Tatsu et al.	525/101
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP-1,209,175 A1	05-2002	EP	Saito et al.	-----
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

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